

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
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Examiner

S. Devi, Ph.D.

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0134407 A1	07-2003	Le Page et al.	435/252.3
	B	US-			
	C	US-			
	D	US-			
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